

Docket No.: 2003P05636

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Stephan Bolz  
Filed : Concurrently herewith  
Title : Device and Method for Measuring Individual Cell Voltages in a Cell  
Stack of an Energy Accumulator

INFORMATION DISCLOSURE STATEMENT

Hon. Commissioner for Patents  
Alexandria, VA 22313-1450

Sir:

In accordance with 37 C.F.R. 1.97(b)(1), copies of the following patents and/or publications are herewith cited to the Office:

European Patent Application EP 0 657 745 A1 (Perelle), dated June 14, 1995, and English abstract thereof;

European Patent Application EP 0 432 639 A2 (Schmidt), dated June 19, 1991, and English abstract thereof;

Japanese Patent Application JP 10 312829 (Ukita), dated November 24, 1998, and English abstract thereof;

Japanese Patent Application JP 9 236624 (Inoue), dated September 9, 1997, and English abstract thereof;

"An Op Amp Transfer Circuit to Measure Voltages in Battery Strings", (Wang, et al.), Journal of Power Sources 109, dated January 14, 2002, pages 253-261;

International Search Report, dated January 24, 2005.

APR 10 2006  
10 APR 2006

If no translation of pertinent portions of any foreign language patents or publications mentioned above is included with the aforementioned copies of those applications, patents and/or publications, it is because no existing translation is readily available to the applicant.

Respectfully submitted,



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Date: April 10, 2006

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1AP9 Rec'd PCT/PTO 10 APR 2006

## FORM PTO-1449 (SUBSTITUTE)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT  
(37 CFR 1.97(b)(1))

Attorney Docket No.:  
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Applicant  
**Stephan Bolz**

Filing Date  
**April 10, 2006**

Group Art Unit

EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A						
	B						
	C						
	D						
	E						
	F						
	G						
	H						
	I						

## FOREIGN PATENT DOCUMENT

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES   NO
/RVM/	J	EP 0 657 745 A1	6/1995	Europe			
/RVM/	K	EP 0 432 639 A2	6/1991	Europe			
/RVM/	L	JP 10 312829	11/1998	Japan			
/RVM/	M	JP 9 236624	9/1997	Japan			
	N						

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

/RVM/		"An Op Amp Transfer Circuit to Measure Voltages in Battery Strings", (Wang, et al.), Journal of Power Sources 109, dated January 14, 2002, pages 253-261

EXAMINER /Richard V Muralidar/

DATE CONSIDERED  
09/30/2008

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.